Session 7C  Analog and Mixed-Signal DFT

Chair: Mani Soma

7C.1  Built-in Self-Test and Fault Diagnosis of Fully Differential Analogue Circuits
     S. Mir, V. Kolarik, M. Lubaszewski, C. Nielsen, B. Courtois

7C.2  A New Built-in-Self-Test Approach for Digital-to-Analog and Analog-to-Digital Converters
     Karim Arabi, Bozena Kaminska, Janusz Rzeszut

7C.3  Fault Detection and Input Stimulus Determination for the Testing of Analog Integrated Circuits Based on Power-Supply Current Monitoring
     Georges Gielen, Zhihua Wang, Willy Sansen